

**Search Notes**

Application/Control No.

10/751,049

Examiner

Y Quach Lee

Applicant(s)/Patent under  
Reexamination

LEE, JAE HUN

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	505 506 507 546 549 368 370 432 457 458	5/24/2005	YMY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	5/24/2005	YMY